

## IEEE Participants

At the time this standard was completed, the Working Group on Nanomaterials Characterization and Use in Large Scale Electronics Manufacturing had the following membership:

**Brent Segal, *Chair***

Herbert Bennett  
Darren K. Brock  
Young Chul Choi  
Hiroyuki Endoh

Jerry Kolbe  
Mike Leibowitz  
Greg Monty  
Axel Mustad  
Brent M. Segal

Nataly Shlamkova  
Leo Stuehler  
Evgeny Titov  
Michael Tomczyk

The following members of the individual balloting committee voted on this standard. Balloters may have voted for approval, disapproval, or abstention.

Herbert Bennett  
Paul Brazis  
Weijen Chen  
Keith Chow

Randall Groves  
Werner Hoelzl  
Philip Lippel  
William Lumpkins  
Bartien Sayogo

Gil Shultz  
Walter Struppler  
Srinivasa Vemuru  
Yingli Wen

When the IEEE-SA Standards Board approved this standard on 3 September 2015, it had the following membership:

**John D. Kulick, *Chair***  
**Jon Walter Rosdahl, *Vice Chair***  
**Richard H. Hulett, *Past Chair***  
**Konstantinos Karachalios, *Secretary***

Masayuki Ariyoshi  
Ted Burse  
Stephen Dukes  
Jean-Philippe Faure  
J. Travis Griffith  
Gary Hoffman  
Michael Janezic

Joseph L. Koepfinger\*  
David J. Law  
Hung Ling  
Andrew Myles  
T. W. Olsen  
Glenn Parsons  
Ronald C. Petersen  
Annette D. Reilly

Stephen J. Shellhammer  
Adrian P. Stephens  
Yatin Trivedi  
Phillip Winston  
Don Wright  
Yu Yuan  
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